

Normally – OFF Silicon Carbide Junction Transistor

 V_{DS} = 1200 V $R_{DS(ON)}$ = 200 mΩ $I_{D@Tc=150^{\circ}C}$ = 6 A $h_{FE Tc=25^{\circ}C}$ = 54

Features

- 175 °C Maximum Operating Temperature
- · Gate Oxide Free SiC Switch
- Exceptional Safe Operating Area
- Excellent Gain Linearity
- Temperature Independent Switching Performance
- Low Output Capacitance
- Positive Temperature Coefficient of R_{DS,ON}
- Suitable for Connecting an Anti-parallel Diode

Advantages

- Compatible with Si MOSFET/IGBT Gate Drive ICs
- > 20 µs Short-Circuit Withstand Capability
- Lowest-in-class Conduction Losses
- High Circuit Efficiency
- Minimal Input Signal Distortion
- · High Amplifier Bandwidth

Package

RoHS Compliant





TO-247AB

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

Absolute Maximum Ratings

Parameter	Symbol	Conditions	Value	Unit	Notes
Drain – Source Voltage	V_{DS}	V _{GS} = 0 V	1200	V	
Continuous Drain Current	I _D	T _C = 150 °C	6	Α	Fig. 19
Continuous Gate Current	I_{GM}		1.5	Α	
Turn-Off Safe Operating Area	RBSOA	T_{VJ} = 175 °C, I_{G} = 1 A, Clamped Inductive Load	$I_{D,max} = 6$	Α	Fig. 16
Short Circuit Safe Operating Area	SCSOA	T_{VJ} = 175 °C, I_G = 1 A, V_{DS} = 800 V, Non Repetitive	20	μs	
Reverse Gate – Source Voltage	V_{SG}		30	V	
Reverse Drain – Source Voltage	V_{SD}		40	V	
Power Dissipation	P _{tot}	T _C = 150 °C	24	W	Fig. 14
Storage Temperature	T _{stg}		-55 to 175	°C	

Electrical Characteristics

Doromotor	Cumbal	Conditions		Value		l lmi4	Notes
Parameter	Symbol	Conditions	Min.	Typical	Max.	Unit	Notes
On State Characteristics							
Drain – Source On Resistance	$R_{DS(ON)}$	$I_D = 6 A$, $T_j = 25 °C$ $I_D = 6 A$, $T_j = 125 °C$ $I_D = 6 A$, $T_j = 175 °C$		200 280 370		mΩ	Fig. 5
Gate Forward Voltage V _{GS(FWD}		I_G = 500 mA, T_j = 25 °C I_G = 500 mA, T_j = 175 °C		3.1 2.9		V	Fig. 4
DC Current Gain	h _{FE}	$V_{DS} = 5 \text{ V}, I_D = 6 \text{ A}, T_j = 25 \text{ °C}$ $V_{DS} = 5 \text{ V}, I_D = 6 \text{ A}, T_j = 175 \text{ °C}$		53 33		_	Fig. 5
Off State Characteristics							
Drain Leakage Current	I _{DSS}	$V_R = 1200 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 25 \text{ °C}$ $V_R = 1200 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 125 \text{ °C}$ $V_R = 1200 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 175 \text{ °C}$		0.5 1 2		μΑ	Fig. 6
Gate Leakage Current	I _{SG}	$V_{SG} = 20 \text{ V}, T_j = 25 ^{\circ}\text{C}$		20		nA	



Electrical Characteristics

Dougmeter	Cumbal	Conditions		Value		I Imi4	Notes
Parameter	Symbol	Conditions	Min.	. Typical Max.		Unit	Notes
Capacitance Characteristics							
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _D = 500 V, f = 1 MHz		700		pF	Fig. 7
Reverse Transfer/Output Capacitance	C _{rss} /C _{oss}	$V_D = 500 \text{ V}, f = 1 \text{ MHz}$		25		pF	Fig. 7
Output Capacitance Stored Energy	Eoss	$V_{GS} = 0 \text{ V}, V_{D} = 1000 \text{ V}, f = 1 \text{ MHz}$		10.2		μJ	Fig. 8
Switching Characteristics ¹							
Internal Gate Resistance, Zero Bias	$R_{G(INT-ZERO)}$	f = 1 MHz, V _{AC} = 25 mV, T _j = 175 °C		5.85		Ω	
Internal Gate Resistance, On	$R_{G(INT-ON)}$	V _{GS} > 2.5 V		0.9		Ω	
Turn On Delay Time	t _{d(on)}			10		ns	
Fall Time, V _{DS}	t _f	$T_j = 25 ^{\circ}\text{C}, V_{DS} = 800 \text{V}, I_D = 6 \text{A}, V_G = 20/-5 \text{V}, Load = 133 \Omega$		26		ns	Fig. 9, 11
Turn Off Delay Time	$t_{d(off)}$	Refer to Fig. 20 for I _G Waveform		24		ns	
Rise Time, V _{DS}	t _r			19		ns	Fig. 10, 12
Turn On Delay Time	$t_{d(on)}$			12		ns	
Fall Time, V _{DS}	t _f	$T_j = 175 ^{\circ}\text{C}, V_{DS} = 800 \text{V}, I_D = 6 \text{A}, V_G = 20/-5 \text{V}, Load = 133 \Omega$		23		ns	Fig. 9
Turn Off Delay Time	$t_{d(off)}$	Refer to Fig. 20 for I _G Waveform		36		ns	
Rise Time, V _{DS}	t _r			14		ns	Fig. 10
Turn-On Energy Per Pulse	E _{on}	T - 05 00 W - 000 W L - 0 A		138		μJ	Fig. 9, 11
Turn-Off Energy Per Pulse	E _{off}	$T_j = 25 ^{\circ}\text{C}, V_{DS} = 800 \text{V}, I_D = 6 \text{A},$ $V_G = 20/-5 \text{V}. \text{Load} = 1.05 \text{mH}$		19		μJ	Fig. 10, 12
Total Switching Energy	E_tot	VG - 20/-5 V, LOAG - 1:05 IIII1		157		μJ	
Turn-On Energy Per Pulse	E _{on}	T = 475 00 V/ = 000 V/ L = 0 A		139		μJ	Fig. 9
Turn-Off Energy Per Pulse	E_{off}	$T_j = 175 ^{\circ}\text{C}, V_{DS} = 800 ^{\circ}\text{V}, I_D = 6 ^{\circ}\text{A}, \ V_G = 20/-5 ^{\circ}\text{V}, \text{Load} = 1.05 ^{\circ}\text{mH}$		12		μJ	Fig. 10
Total Switching Energy	E_tot	vg 25/ 5 v, 2000 - 1.00 mm		151		μJ	

 $^{^{1}}$ – All times are relative to the Drain-Source Voltage V_{DS}

Thermal Characteristics

Thermal resistance, junction - case	R_{thJC}	1.03	°C/W Fig	. 17

Figures

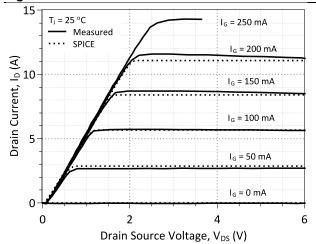


Figure 1: Typical Output Characteristics at 25 °C

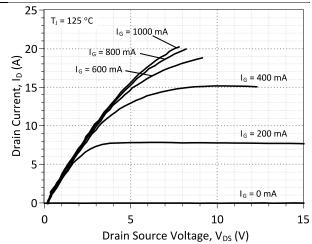


Figure 2: Typical Output Characteristics at 125 °C

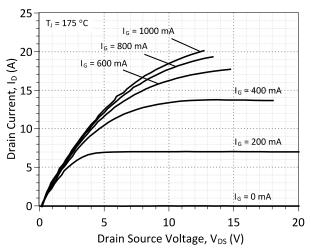


Figure 3: Typical Output Characteristics at 175 °C

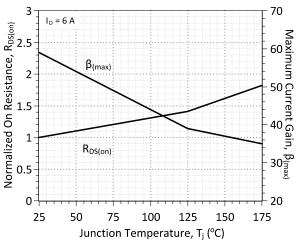


Figure 5: Normalized On-Resistance and Current Gain vs. Temperature

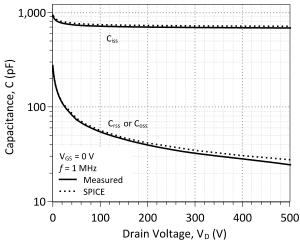


Figure 7: Input, Output, and Reverse Transfer Capacitance

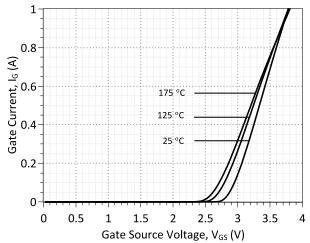


Figure 4: Typical Gate Source I-V Characteristics vs. Temperature

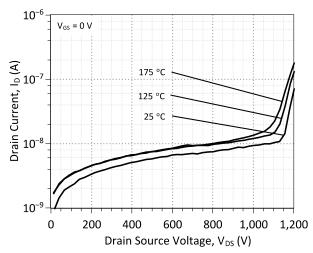


Figure 6: Typical Blocking Characteristics

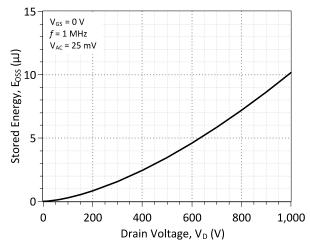


Figure 8: Output Capacitance Stored Energy



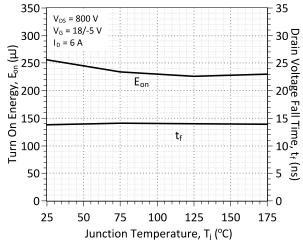


Figure 9: Typical Turn On Energy Losses and Switching Times vs. Temperature

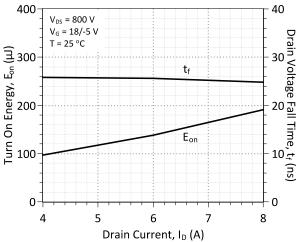


Figure 11: Typical Turn On Energy Losses and Switching Times vs. Drain Current

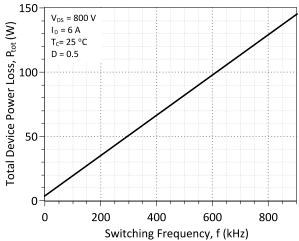


Figure 13: Typical Hard Switched Device Power Loss vs. Switching Frequency ²

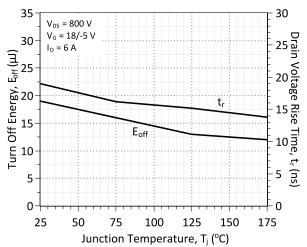


Figure 10: Typical Turn Off Energy Losses and Switching Times vs. Temperature

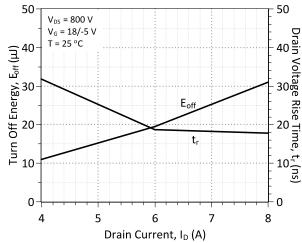


Figure 12: Typical Turn Off Energy Losses and Switching Times vs. Drain Current

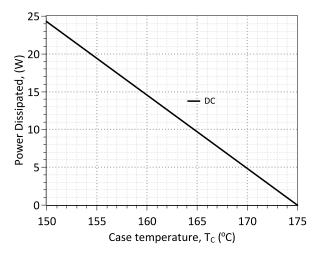


Figure 14: Power Derating Curve

² – Representative values based on device conduction and switching loss. Actual losses will depend on gate drive conditions, device load, and circuit topology.

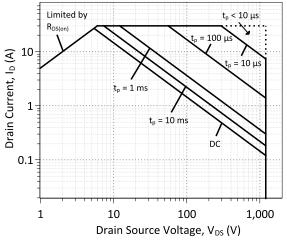


Figure 15: Forward Bias Safe Operating Area at T_c = 25 °C

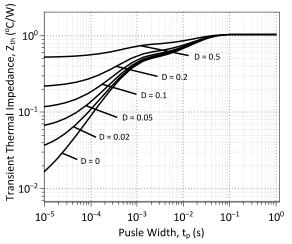


Figure 17: Transient Thermal Impedance

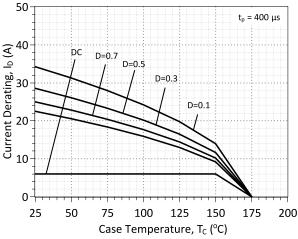


Figure 19: Drain Current Derating vs. Temperature

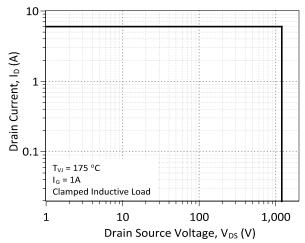


Figure 16: Turn-Off Safe Operating Area

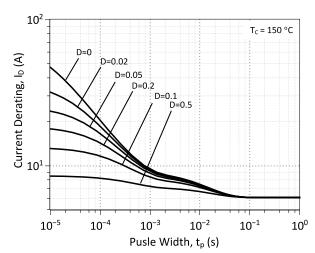


Figure 18: Drain Current Derating vs. Pulse Width

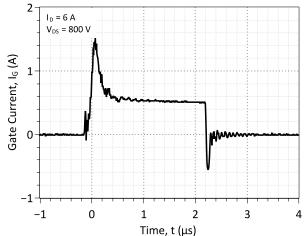


Figure 20: Typical Gate Current Waveform



Driving the GA06JT12-247

A: Gate Drive Theory of Operation

The SJT is a current controlled transistor which requires a positive gate current for turn-on as well as to remain in on-state. An ideal gate current waveform for ultra-fast switching of the SJT, while maintaining low gate drive losses, is shown in Figure 21.

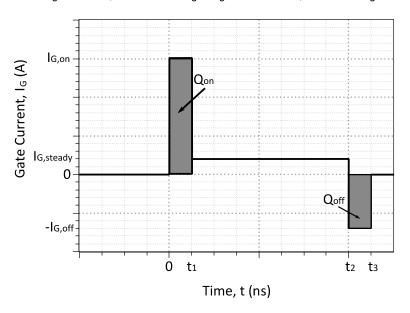


Figure 21: Idealized Gate Current Waveform

A:1: Gate Currents, $I_{G,pk}$ /- $I_{G,pk}$ and Voltages during Turn-On and Turn-Off

An SJT is rapidly switched from its blocking state to on-state, when the necessary gate charge, Q_G , for turn-on is supplied by a burst of high gate current, $I_{G,on}$, until the gate-source capacitance, C_{GS} , and gate-drain capacitance, C_{GD} , are fully charged.

$$I_{G,on}*t_1 \geq Q_{gs} + Q_{gd}$$

The $I_{G,pon}$ pulse should ideally terminate, when the drain voltage falls to its on-state value, in order to avoid unnecessary drive losses during the steady on-state. In practice, the rise time of the $I_{G,on}$ pulse is affected by the parasitic inductances, L_{par} in the TO-247 package and drive circuit. A voltage developed across the parasitic inductance in the source path, L_s , can de-bias the gate-source junction, when high drain currents begin to flow through the device. The applied gate voltage should be maintained high enough, above the $V_{GS,ON}$ level to counter these effects.

A high negative peak current, $-I_{G,off}$ is recommended at the start of the turn-off transition, in order to rapidly sweep out the injected carriers from the gate, and achieve rapid turn-off. While satisfactory turn off can be achieved with $V_{GS} = 0$ V, a negative gate voltage V_{GS} may be used in order to speed up the turn-off transition.

A:2: Steady On-State

After the device is turned on, I_G may be advantageously lowered to $I_{G,steady}$ for reducing unnecessary gate drive losses. The $I_{G,steady}$ is determined by noting the DC current gain, h_{FE} , of the device.

The desired $I_{G,steady}$ is determined by the peak device junction temperature T_J during operation, drain current I_D , DC current gain h_{FE} , and a 50 % safety margin to ensure operating the device in the saturation region with low on-state voltage drop by the equation:

$$I_{G,steady} \approx \frac{I_D}{h_{FE}(T,I_D)} * 1.5$$



B: Gate Drive Implementation Examples

B:1: Using the IXYS IX2204 Gate Driver

The IXYS IX2204 is a dual output gate drive integrated circuit which can be used to drive an SJT by supplying the required gate drive current I_G in a low-power gate drive solution. This configuration features an external gate capacitor, C_G , which creates the brief current peak $I_{G,on}$ during device turn-on and $I_{G,off}$ during turn-off for fast switching and an external gate resistor $R_{G(EXT)}$ to set the continuous gate current $I_{G,steady}$ required for the device to remain on. This configuration is shown in Figure 2 with further details provided below.

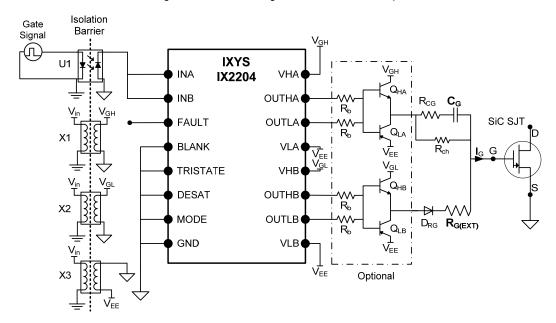


Figure 2: Gate drive configuration using an IXYS IX2204 gate drive IC.

Table 1: Recommended Component List for implementing the IX2204 based Gate Drive for the GA06JT12-247

Reference	Component	Description	Suggested Part
R _{G(EXT)}	Gate Resistance, External	2.0 Ω, 2 W	CRM2512-JW-2R2ELF
C _G	Gate Capacitance	10 nF	C1812C103J1GACTU
R _{cg}	Damping Resistor	1.0 Ω, 0.5 W	ERJ-1TYJ1R0U
D_{RG}	Silicon Schottky Diode	40 V, 2 A	SS24T3G
R₀	BJT Base Resistor	1.0 Ω, 0.5 W	ERJ-1TYJ1R0U
Q _{HA} , Q _{HB}	Current Boost NPN	40 V, 8 A, Silicon NPN BJT	MJD44H11
Q _{LA} , Q _{LB}	Current Boost PNP	40 V, 8 A, Silicon PNP BJT	MJD45H11
U1	Signal Isolator	Opto-Isolator –or– Transformer Isolator	ACPL-4800 / ADUM3210
X1	DC/DC Converter, V _{GH} Supply	V_{OUT} = +20 V, V_{IN} = +12 V, 2 W, V_{ISO} = 5.2 kV	MGJ2D122005SC
X2	DC/DC Converter, V _{GL} Supply	$V_{OUT} = +5 \text{ V}, V_{IN} = +12 \text{ V}, 3 \text{ W}, V_{ISO} = 3.0 \text{ kV}$	MEV3S1205SC
X3	DC/DC Converter, V _{EE} Supply	$V_{OUT} = -5 \text{ V}, V_{IN} = +12 \text{ V}, 2 \text{ W}, V_{ISO} = 5.2 \text{ kV}$	MGJ2D122005SC

B:2: Voltage Supply Selection

The IX2204 gate drive design requires three supply voltages V_{GH} , V_{GL} , and V_{EE} (listed in Table 2) optionally supplied through DC/DC converters. During device turn-on, V_{GH} charges the external capacitor C_G thereby delivering the narrow width, high current pulse $I_{G,on}$ to the SJT gate and charges the SJT's internal terminal capacitances C_{GD} and C_{GS} . For a given level of parasitic inductance in the gate circuit and SJT package, the rise time of $I_{G,on}$ is controlled by the choice of V_{GH} and C_{G} . During the steady on-state, V_{GL} in combination with the internal and external gate resistances provides a continuous gate current for the GA06JT12-247 to remain on. The V_{EE} supply sets the gate negative during turn-off and steady off-state for faster switching and to avoid spurious turn-on which may be caused by external circuit noise. The power rating of the voltage supplies should be adequate to meet the gate drive power requirements as determined by

$$P_{min,VGH} = \frac{1}{2} C_G V_{GH}^2 f_{sw}$$

$$P_{min,VEE} = \frac{1}{2} C_G V_{EE}^2 f_{sw}$$

$$P_{min,VGL} = V_{GL}I_{G,steady} D$$

Table 2: IX2204 Gate Drive Example (Component List
--------------------------------------	----------------

Symbol	Parameter	Values		
		Range	Typical	
V_{GH}	Supply Voltage, Driver Output A	15 – 20	+ 20.0	
V_{GL}	Supply Voltage, Driver Output B	5.0 – 7.0	+ 5.0	
V _{EE}	Negative Supply Voltage	-10 – GND	- 5.0	

B:3: Gate Capacitor C_G Selection

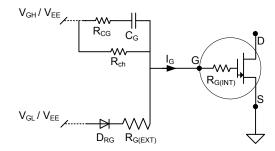


Figure 23: Primary gate drive circuit passive components with series gate resistance Schottky rectifier.

An external gate capacitor C_G connected directly to the device gate pin delivers the positive current peak $I_{G,on}$ during device turn-on and the negative current peak $I_{G,off}$ during turn-off. A low value resistor R_{CG} is connected in series with C_G to damp potential high-frequency oscillation. A high value resistor R_{ch} in parallel with C_G sets the SJT gate to a defined potential (- V_{EE}) during steady off-state.

At device turn-on, C_G is pulled to V_{GH} which produces a transient peak of gate voltage and current. This current peak rapidly charges the internal SJT C_{GS} and C_{GD} capacitances. A Schottky diode, D_{RG} , in series with $R_{G(EXT)}$ blocks any C_G induced current from draining out through $R_{G(EXT)}$ and ensures that all of the charge within C_G flows only into the device gate, allowing for an ultra-fast device turn-on. During steady on-state, a potential of V_{GH} - V_{GS} = V_{GH} - 3 V is across C_G . When the device is turned off, C_G is pulled to negative V_{EE} and V_{GS} is pulled to a transient peak of $V_{GS,turn-off}$ = V_{EE} - (V_{GH} - 3 V), this induces the negative current peak $I_{G,off}$ out of the gate which discharges the SJT internal capacitances.

B:4: External Gate Resistor R_{G(EXT)} Selection

An external gate resistor $R_{G(EXT)}$ connected directly to the SJT gate pin acts to deliver a continuous current $I_{G,steady}$ during steady on-state. The gate current is determined by:

$$I_{G,steady} = \frac{V_{GL} - V_{GS(FWD)} - V_{Sch}}{R_{G(EXT)} + R_{G(INT-ON)}}$$

The on-state gate-source voltage $V_{\text{GS(FWD)}}$ can be approximated to 3 V and the Schottky on-state voltage V_{Sch} can be approximated to 0.3 V which simplifies the equation to:

$$I_{G,steady} = \frac{V_{GL} - 3.3V}{R_{G(EXT)} + R_{G(INT-ON)}}$$

The desired $I_{G,steady}$ is determined by the peak device junction temperature T_J during operation, drain current I_D , DC current gain β , and a 50 % safety margin to avoid operating the device in saturation. $I_{G,steady}$ may also be approximated from the temperature dependent on-state curves of the device in Figures Error! Reference source not found. – Error! Reference source not found., provided that a 50 % increase is given.

Table 3: Passive Output Component List

Symbol	Domonoston	,		
	Parameter	Range	Typical	Units
C _G	Gate Capacitor, External	5 – 20	10	nF
R _{cg}	Damping Resistor of Gate Capacitor	0.5 - 2.0	1.0	Ω
₹ _{ch}	Charging Resistor	500 – 10k	1k	Ω
R _{G(EXT)}	Gate Resistor, External	0.4 – 5	2.0	Ω
R _{G(INT-ON)}	Gate Resistance, Internal, On-State	0.6 – 1.5	0.9	Ω
D_{RG}	Schottky Diode of Gate Resistor			



B:5: Optional Gate Current Boost Network

An optional output totem-pole network may be attached to the IX2204 output pins as shown in Figure 22 using either silicon BJTs (shown) or MOSFETs. This configuration allows the IX2204 to directly drive the BJT bases or MOSFET gates and not supply the full peak and steady state gate current entering the SJT gate. The primary gate current delivery device is transferred to the discrete components which have higher power dissipation ratings than the IX2204.

B:6: Voltage Supply Isolation

The DC/DC supply voltage converters are suggested to provide isolation at a minimum of twice the working V_{DS} on the SJT transistor during off-state to provide adequate protection to circuitry external to the gate drive circuit. Suggested DC/DC converters have an isolation of 3.0 kV or greater. Alternatively, DC/DC converter galvanic isolation may be bypassed and direct connection of variable voltage supplies may be done, this may be convenient during testing and prototyping but carries risk and is not suggested for extended usage.

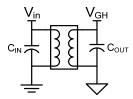


Figure 24: Typical DC/DC converter configuration

B:7: Signal Isolation

The gate supply signal is suggested to be isolated to twice the working V_{DS} on the SJT during off-state to provide adequate protection to circuitry external to the gate drive circuit. This may be done using opto or galvanic isolation techniques.

B:8: Additional Features

The IX2204 has additional functionality available which is unused in the given configuration. Desaturation detection and fault status monitoring may be implemented by un-grounding the DESAT, BLANK, and TRISTATE pins and configuring them as recommended in the IX2204 datasheet, available from IXYS. Active miller clamping is also available on other gate drive ICs which may also be desired in some SJT switching applications but is not required, refer to specific gate drive IC datasheets for more information.

C: Alternative Gate Drive ICs

dividual product manufacturers.

Table 4 features a partial list of alternative gate drive ICs which may be used for driving the GA06JT12-247; specific product information should be obtained from the individual product manufacturers.

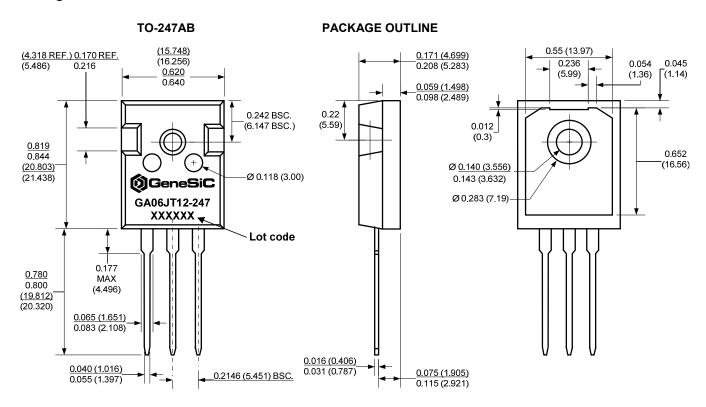
Table 4: Additional Commercial Gate Drivers Compatible with GA06JT12-247

				Features		
Manufacturer	Part Number	Optical Signal Isolation	Desaturation Detection	Active Miller Gate Clamping ³	High Side Capability	Number of Outputs
Avago Tech.	HCPL-316J	✓	✓	-	✓	1
Avago Tech.	HCPL-322J	✓	✓	✓	✓	1
IXYS	IXD_604	-	-	-	✓	2
IXYS	IXD_614	-	-	-	✓	1
Micrel	MIC4452YN	_	_	_	✓	1
Microsemi	LX4510	_	_	_	✓	1
Texas Instruments	UCC27322	-	_	-	✓	1

³ – Active Miller Gate Clamping recommended for V_{EE} = GND switching applications as SJT and/or output BJT secondary gate discharge path.



Package Dimensions:



NOTE

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History						
Date	Revision	Comments	Supersedes			
2014/08/26	4	Updated Electrical Characteristics				
2013/11/13	3	Updated Electrical Characteristics				
2013/06/24	2	Updated Electrical Characteristics				
2013/02/21	1	Revised Electrical Characteristics				
2012/11/30	0	Initial Release				

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SPICE Model Parameters

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/images/products-sic/sjt/GA06JT12-247-SPICE.pdf) into LTSPICE (version 4) software for simulation of the GA06JT12-247.

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MODEL OF GeneSiC Semiconductor Inc.
     $Revision: 1.2
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     $Date: 26-AUG-2014
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* PARTICULAR PURPOSE."
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.model GA06JT12 NPN
+ IS
          5.08E-47
+ ISE
           1.26E-28
           3.2
+ EG
+ BF
           58.31
           0.55
+ BR
           200
+ IKF
+ NF
           1
+ NE
          1.892
          5.85
+ RB
          0.9
+ RBM
+ IRB
          1e-4
+ RE
           0.1039
           0.06188
+ RC
+ CJC
           2.73E-10
           3.04
+ VJC
          0.448
+ MJC
+ CJE
          6.86E-10
           2.89
+ VJE
+ MJE
          0.466
+ XTI
          -1.33
+ XTB
+ TRC1
          1.90E-2
+ VCEO
           1200
+ ICRATING 6
           GeneSiC Semiconductor
```

*End of GA06JT12 SPICE Model